

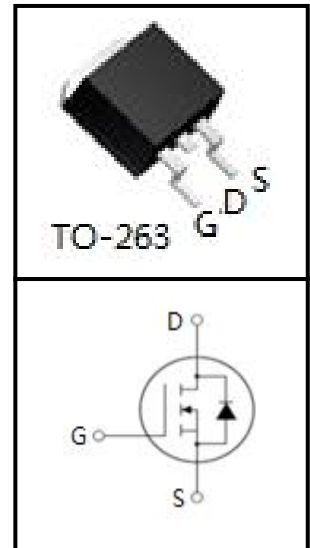
## 80V N-Channel Split Gate MOSFET

### FEATURES

- Trench Power MOSFET Technology
- Low  $R_{DS(ON)}$
- Low Gate Charge
- Optimized For Fast-switching Applications

### APPLICATIONS

- DC/DC Converter
- Ideal for high-frequency switching and synchronous rectification



### Device Marking and Package Information

Device	Package	Marking
CSB08N6P5	TO-263	CSB08N6P5

### Absolute Maximum Ratings at $T_J = 25^\circ\text{C}$ unless otherwise noted

Parameter	Symbol	Value	Unit
Drain-Source Voltage ( $V_{GS} = 0\text{V}$ )	$V_{DSS}$	80	V
Continuous Drain Current $T_C = 25^\circ\text{C}$ (note1)	$I_D$	130	A
Continuous Drain Current $T_C = 100^\circ\text{C}$ (note1)		100	
Pulsed Drain Current (note2)	$I_{DM}$	280	A
Gate Source Voltage	$V_{GSS}$	$\pm 20$	V
Single Pulse Avalanche Energy (note3)	$E_{AS}$	100	mJ
Power Dissipation $T_C = 25^\circ\text{C}$ (note4)	$P_D$	56	W
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55~+150	$^\circ\text{C}$

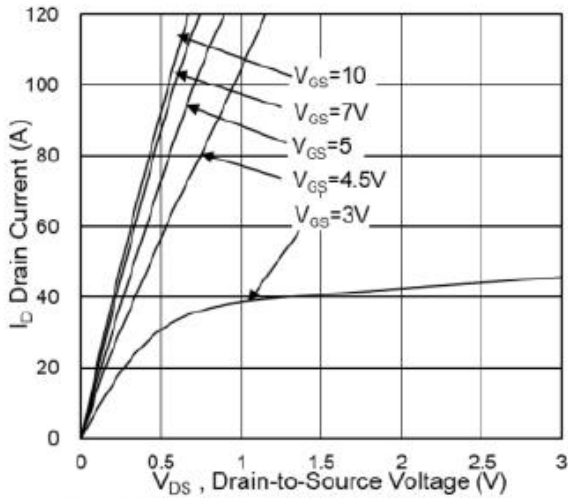
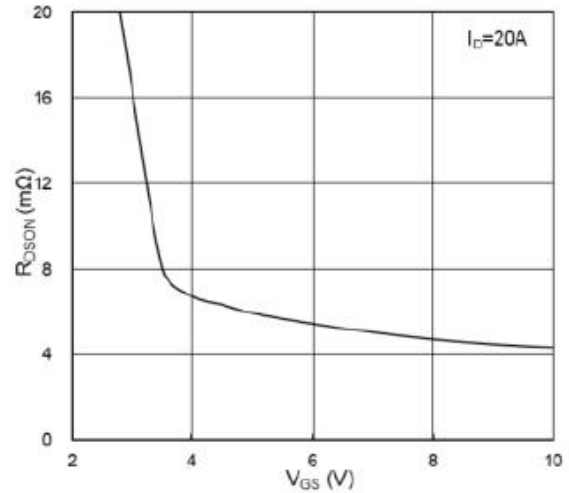
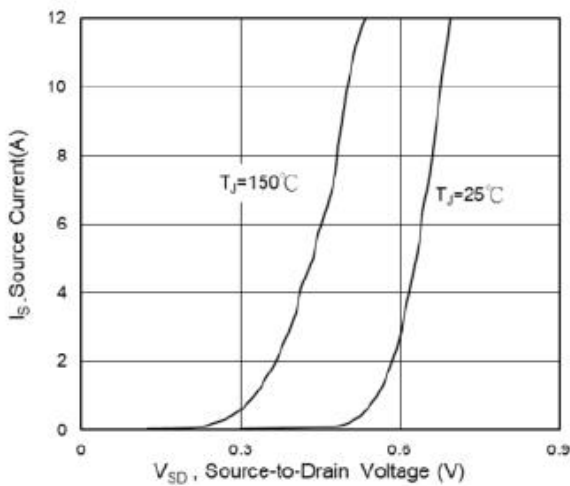
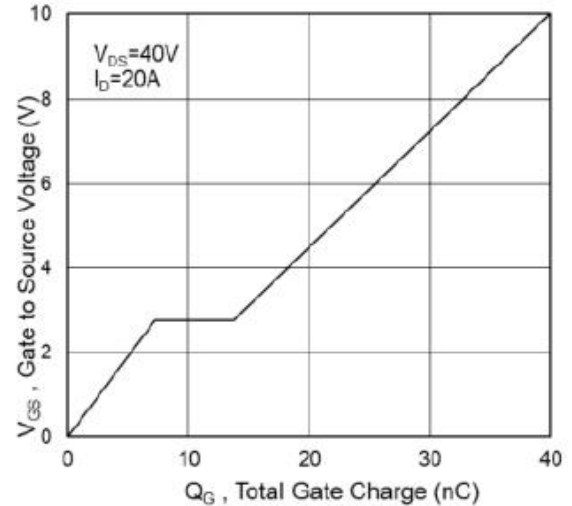
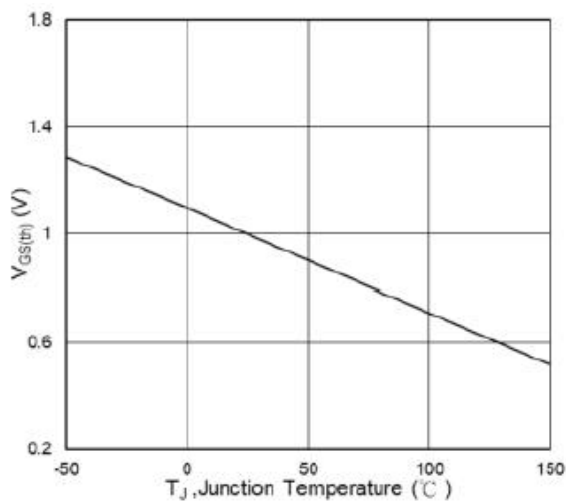
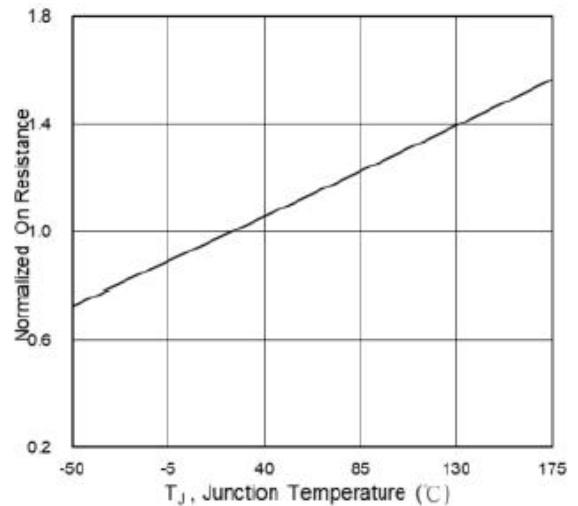
### Thermal Characteristics

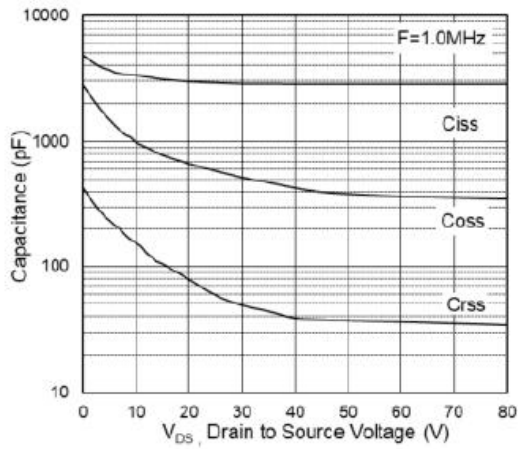
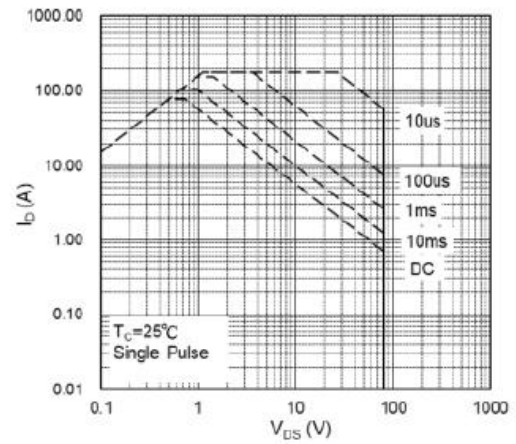
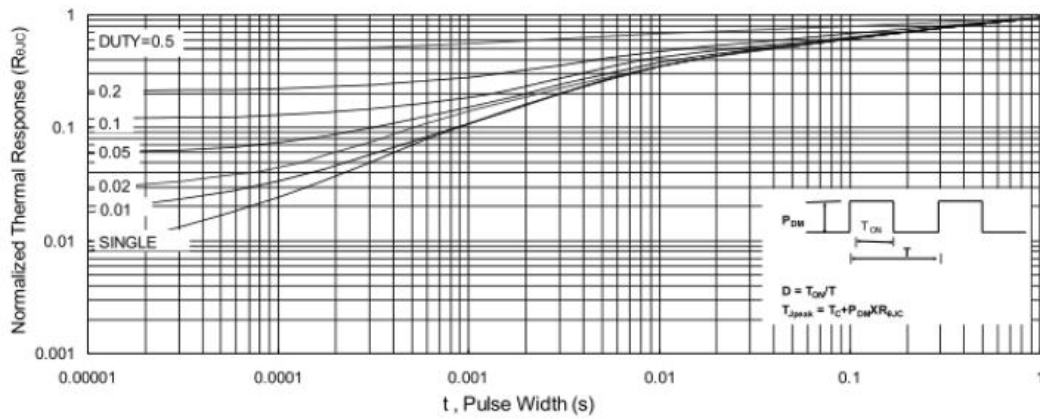
Parameter	Symbol	Value	Unit
Thermal Resistance, Junction-to-Case	$R_{\theta JC}$	0.4	$^\circ\text{C/W}$
Thermal Resistance, Junction-to-Ambient	$R_{\theta JA}$	62.5	

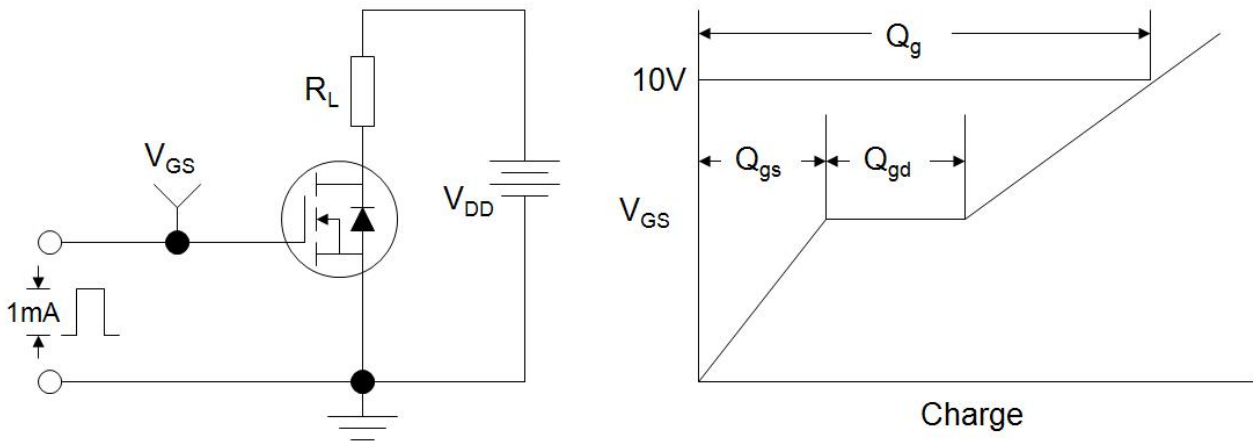
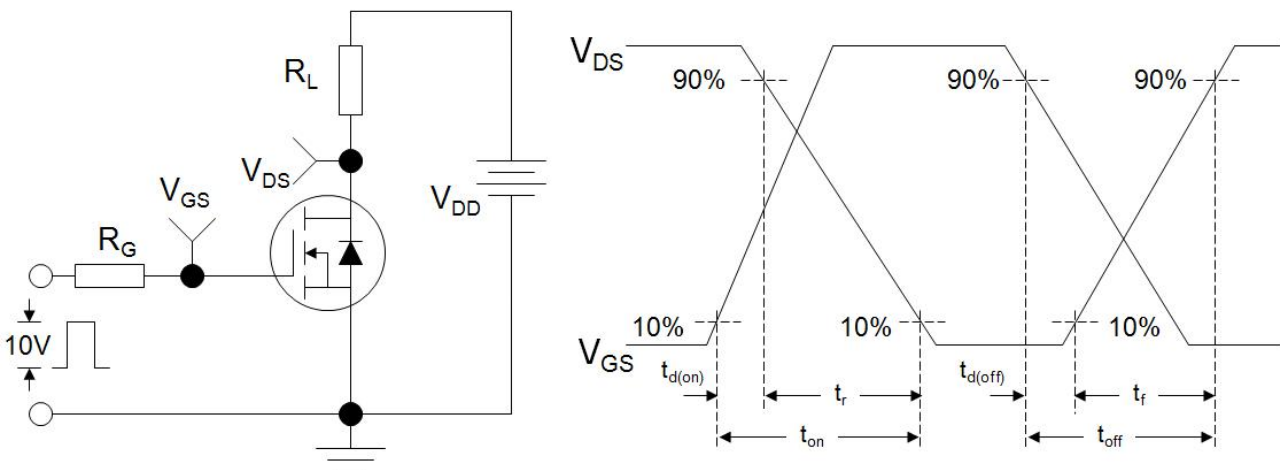
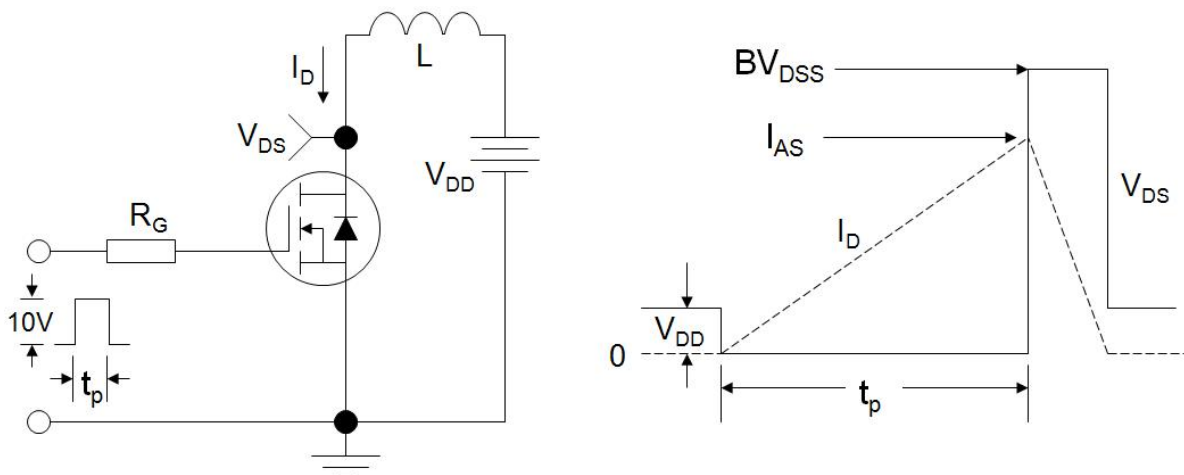
Electrical Characteristics $T_J = 25^\circ\text{C}$ unless otherwise specified						
Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{(BR)DSS}$	$V_{GS} = 0V, I_D = 250\mu A$	80	--	--	V
Zero Gate Voltage Drain Current	$I_{DSS}$	$V_{DS} = 64V, V_{GS} = 0V, T_J = 25^\circ\text{C}$	--	--	1	$\mu A$
		$V_{DS} = 64V, V_{GS} = 0V, T_J = 100^\circ\text{C}$	--	--	5	$\mu A$
Gate-Source Leakage	$I_{GSS}$	$V_{GS} = \pm 20V$	--	--	$\pm 100$	nA
Gate-Source Threshold Voltage	$V_{GS(th)}$	$V_{DS} = V_{GS}, I_D = 250\mu A$	1.2	--	2.5	V
Drain-Source On-Resistance (note2)	$R_{DS(on)}$	$V_{GS} = 10V, I_D = 30A$	--	4.5	6.5	m $\Omega$
		$V_{GS} = 4.5V, I_D = 20A$	--	6.5	8.5	m $\Omega$
<b>Dynamic</b>						
Input Capacitance	$C_{iss}$	$V_{GS} = 0V,$ $V_{DS} = 40V,$ $f = 1.0\text{MHz}$	--	2900	--	pF
Output Capacitance	$C_{oss}$		--	420	--	
Reverse Transfer Capacitance	$C_{rss}$		--	40	--	
Total Gate Charge (4.5V)	$Q_g$	$V_{DS} = 40V, I_D = 15A,$ $V_{GS} = 10V$	--	40	--	nC
Gate-Source Charge	$Q_{gs}$		--	7.2	--	
Gate-Drain Charge	$Q_{gd}$		--	6.5	--	
Turn-on Delay Time	$t_{d(on)}$	$V_{DS} = 40V, I_D = 15A$ $, R_G = 3\Omega$	--	8.3	--	ns
Turn-on Rise Time	$t_r$		--	4.2	--	
Turn-off Delay Time	$t_{d(off)}$		--	36	--	
Turn-off Fall Time	$t_f$		--	6.9	--	
<b>Body Diode Characteristics</b>						
Source-Drain Current(Body Diode)	$I_S$		--	--	130	A
Pulsed Source-Drain Current(Body Diode)	$I_{SDM}$		--	--	280	
Body Diode Voltage	$V_{SD}$	$T_J = 25^\circ\text{C}, I_{SD} = 1A, V_{GS} = 0V$	--	--	1.2	V

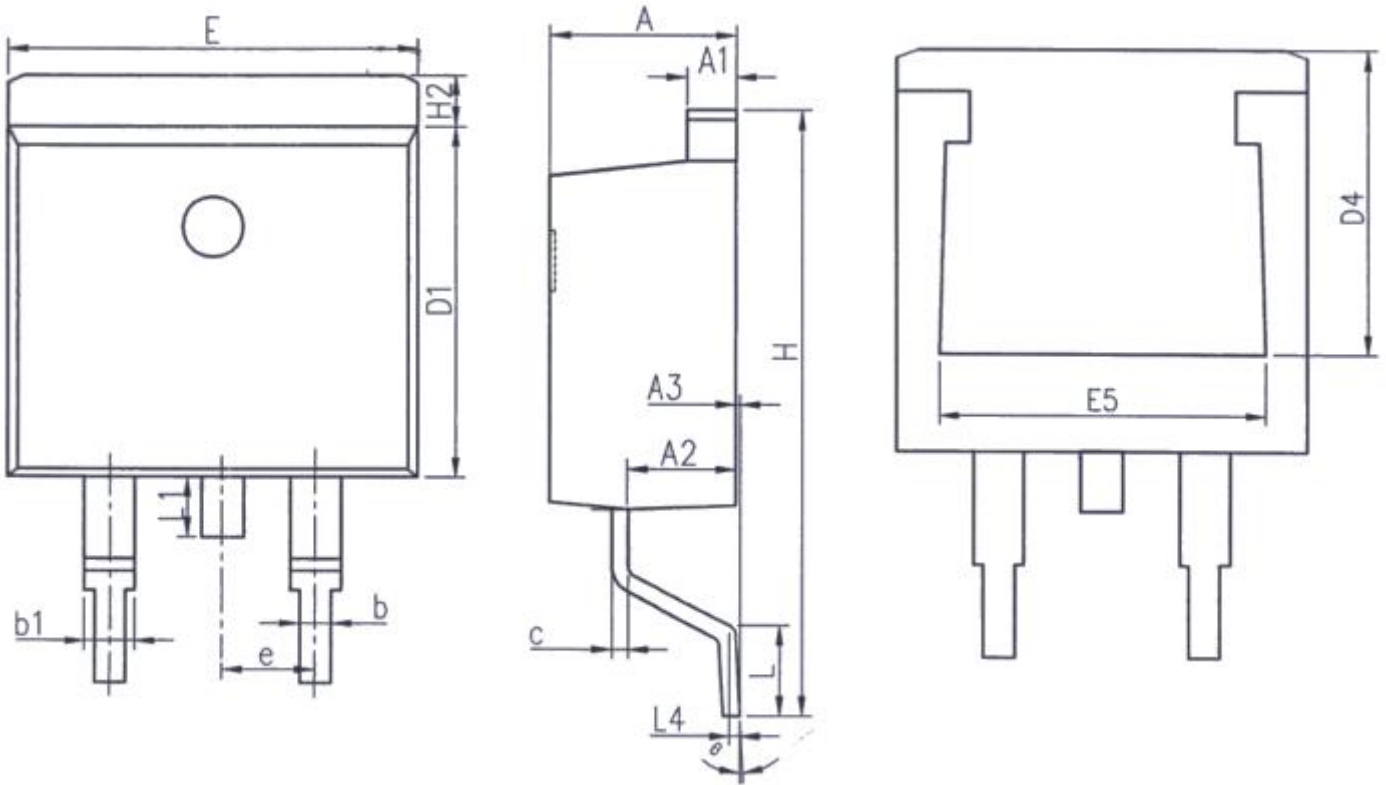
**Notes**

1. The data tested by surface mounted on a 1 inch<sup>2</sup> FR-4 board with 2OZ copper.
2. The data tested by pulsed , pulse width  $\leq 300\mu s$  , duty cycle  $\leq 2\%$
3. The EAS data shows Max. rating . The test condition is  $V_{DD} = 25V, V_{GS} = 10V, L = 0.1mH$
4. The power dissipation is limited by 175 $^\circ\text{C}$  junction temperature
5. The data is theoretically the same as  $I_D$  and  $I_{DM}$  , in real applications , should be limited by total power dissipation.

**Typical Characteristics**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

**Fig.1 Typical Output Characteristics**

**Fig.2 On-Resistance vs. G-S Voltage**

**Fig.3 Source Drain Forward Characteristics**

**Fig.4 Gate-Charge Characteristics**

**Fig.5 Normalized  $V_{GS(th)}$  vs.  $T_J$** 

**Fig.6 Normalized  $R_{DS(on)}$  vs.  $T_J$**

**Typical Characteristics**  $T_j = 25^\circ\text{C}$ , unless otherwise noted

**Fig.7 Capacitance**

**Fig.8 Safe Operating Area**

**Fig.9 Normalized Maximum Transient Thermal Impedance**

**Figure A: Gate Charge Test Circuit and Waveform**

**Figure B: Resistive Switching Test Circuit and Waveform**

**Figure C: Unclamped Inductive Switching Test Circuit and Waveform**


**TO-263**


Unit: mm		
Symbol	Min.	Max.
E	9.86	10.36
E5	7.06	-
e	2.54BSC	
H	14.70	15.50
H2	1.07	1.47
L	2.00	2.60
L1	1.40	1.70
L4	0.25BSC	
θ	0°	9°

Unit: mm		
Symbol	Min.	Max.
A	4.37	4.77
A1	1.22	1.42
A2	2.49	2.89
A3	0.00	0.25
b	0.70	0.96
b1	1.17	1.47
c	0.30	0.53
D1	8.50	8.90
D4	6.60	-

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